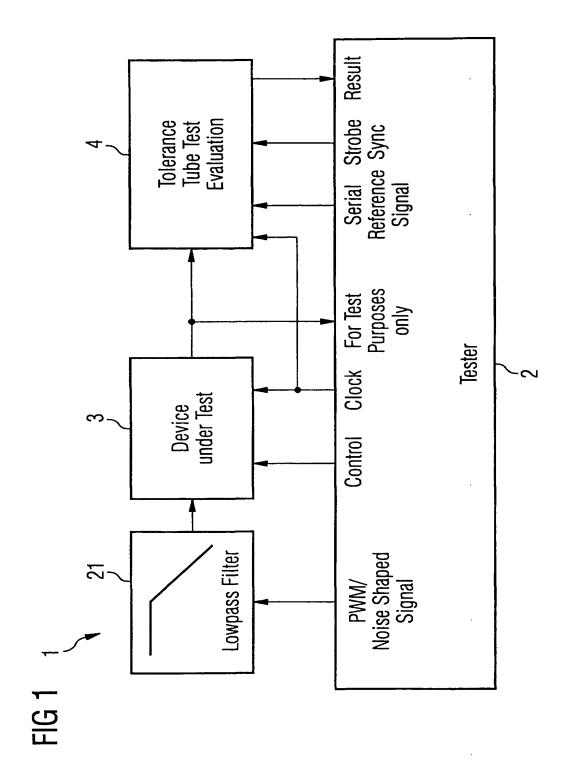
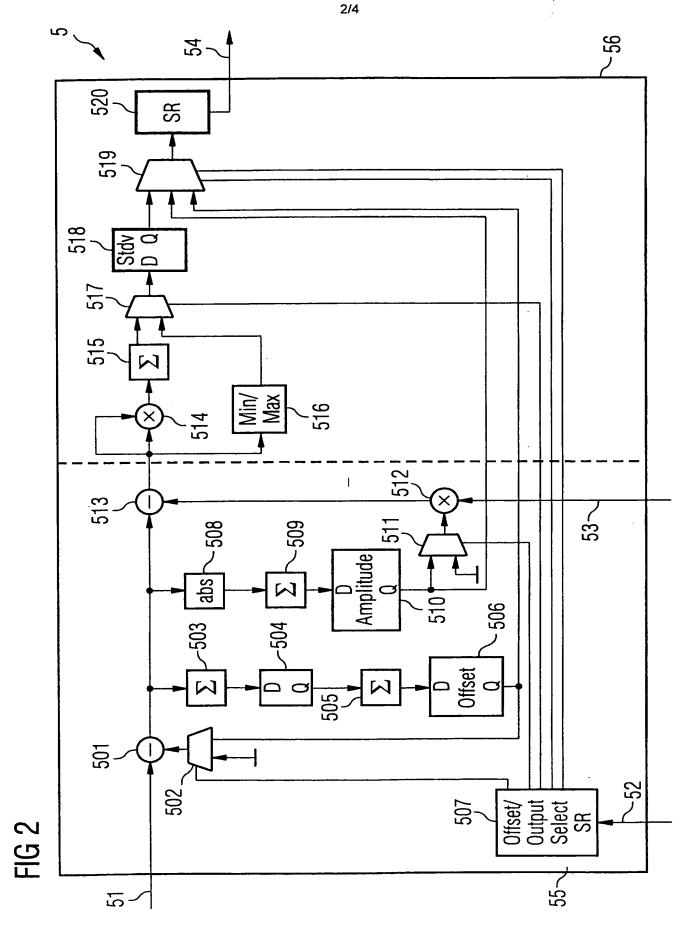
## Docket No. 1431.144.101/FIN 503 PCT/US ELECTRICAL CIRCUIT AND METHOD FOR TESTING ELECTRONIC COMPONENT Claus Dworski et al. 1/4



## Docket No. 1431.144.101/FIN 503 PCT/US ELECTRICAL CIRCUIT AND METHOD FOR TESTING ELECTRONIC COMPONENT

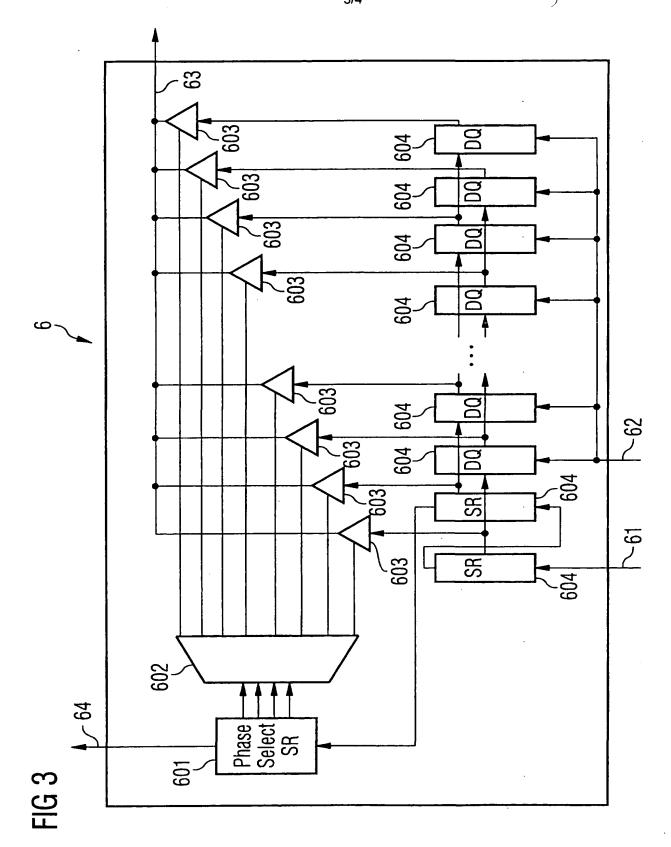
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Claus Dworski et al. 3/4



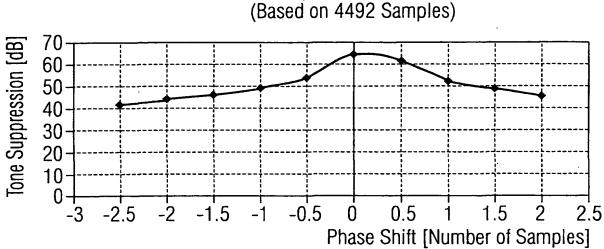
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FIG 4





Phase Shift [Number of Samples]	-2.5	-2	-1.5	-1	-0.5	0	0.5	1	1.5	2
Tone Suppression [dB]	42.4	44.2	46.4	49.4	54	64.6	61.8	53.1	48.8	46